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# RF POWER MOSFETs

## N-CHANNEL ENHANCEMENT MODE

150V 90W 120MHz

The ARF449A and ARF449B comprise a symmetric pair of common source RF power transistors designed for push-pull scientific, commercial, medical and industrial RF power amplifier applications up to 120 MHz.

- Specified 150 Volt, 81.36 MHz Characteristics:
  - **Output Power = 90 Watts.**
  - Gain = 13dB (Class C)
  - Efficiency = 75%

- Low Cost Common Source RF Package.
- Very High Breakdown for Improved Ruggedness.
- Low Thermal Resistance.
- Nitride Passivated Die for Improved Reliability.

#### **MAXIMUM RATINGS**

All Ratings:  $T_C = 25$ °C unless otherwise specified.

Symbol	Parameter	ARF449A/449B(G)	UNIT	
V <sub>DSS</sub>	Drain-Source Voltage	450	Volts	
V <sub>DGO</sub>	Drain-Gate Voltage	450	VOILS	
I <sub>D</sub>	Continuous Drain Current @ T <sub>C</sub> = 25°C	9	Amps	
V <sub>GS</sub>	Gate-Source Voltage	±30	Volts	
P <sub>D</sub>	Total Power Dissipation @ T <sub>C</sub> = 25°C	165	Watts	
$R_{\theta JC}$	Junction to Case	0.76	°C/W	
T <sub>J</sub> ,T <sub>STG</sub>	Operating and Storage Junction Temperature Range	-55 to 150	°C	
T <sub>L</sub>	Lead Temperature: 0.063" from Case for 10 Sec.	300		

#### STATIC ELECTRICAL CHARACTERISTICS

Symbol	Characteristic / Test Conditions	MIN	TYP	MAX	UNIT	
BV <sub>DSS</sub>	Drain-Source Breakdown Voltage $(V_{GS} = 0V, I_D = 250 \mu A)$	450			Volts	
V <sub>DS</sub> (ON)	On State Drain Voltage $^{\textcircled{1}}$ (I <sub>D</sub> (ON) = 5A, V <sub>GS</sub> = 10V)			4		
	Zero Gate Voltage Drain Current (V <sub>DS</sub> = V <sub>DSS</sub> , V <sub>GS</sub> = 0V)			25	^	
DSS	Zero Gate Voltage Drain Current $(V_{DS} = 0.8 V_{DSS}, V_{GS} = 0V, T_{C} = 125^{\circ}C)$			250	μΑ	
I <sub>GSS</sub>	Gate-Source Leakage Current $(V_{GS} = \pm 30V, V_{DS} = 0V)$			±100	nA	
g <sub>fs</sub>	Forward Transconductance $(V_{DS} = 25V, I_{D} = 5A)$	3	5.8		mhos	
V <sub>GS</sub> (TH)	Gate Threshold Voltage $(V_{DS} = V_{GS}, I_{D} = 50 \text{mA})$	2		5	Volts	

CAUTION: These Devices are Sensitive to Electrostatic Discharge. Proper Handling Procedures Should Be Followed.

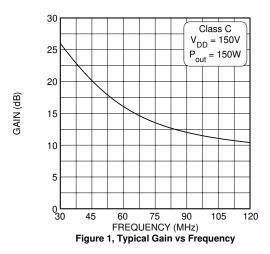
Symbol	Characteristic	Test Conditions	MIN	TYP	MAX	UNIT
C <sub>iss</sub>	Input Capacitance	V <sub>GS</sub> = 0V		980	1200	
C <sub>oss</sub>	Output Capacitance	$V_{DS} = 150V$		87	120	pF
C <sub>rss</sub>	Reverse Transfer Capacitance	f = 1 MHz		25	40	
t <sub>d(on)</sub>	Turn-on Delay Time	V <sub>GS</sub> = 15V		5	10	
t <sub>r</sub>	Rise Time	$V_{DD} = 0.5 V_{DSS}$		3.1	7	ns
t <sub>d(off)</sub>	Turn-off Delay Time	I <sub>D</sub> = I <sub>D[Cont.]</sub> @ 25°C		15	25	113
t <sub>f</sub>	Fall Time	R <sub>G</sub> = 1.6ý		3	7	

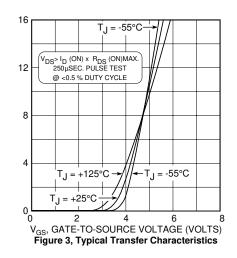
#### **FUNCTIONAL CHARACTERISTICS**

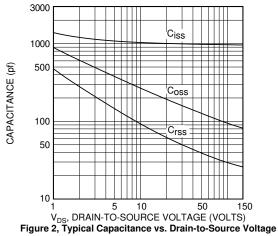
Symbol	Characteristic	Test Conditions	MIN	TYP	MAX	UNIT
G <sub>PS</sub>	Common Source Amplifier Power Gain	f = 81.36 MHz	12	13		dB
η	Drain Efficiency	$V_{GS} = 0V$ $V_{DD} = 150V$	70	75		%
Ψ	Electrical Ruggedness VSWR 20:1	P <sub>out</sub> = 90W	No Degradation in Output Power			

①Pulse Test: Pulse width < 380 μS, Duty Cycle < 2%

APT Reserves the right to change, without notice, the specifications and information contained herein.







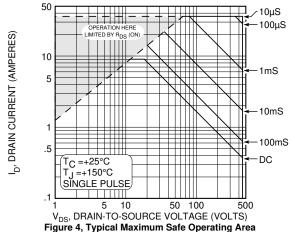
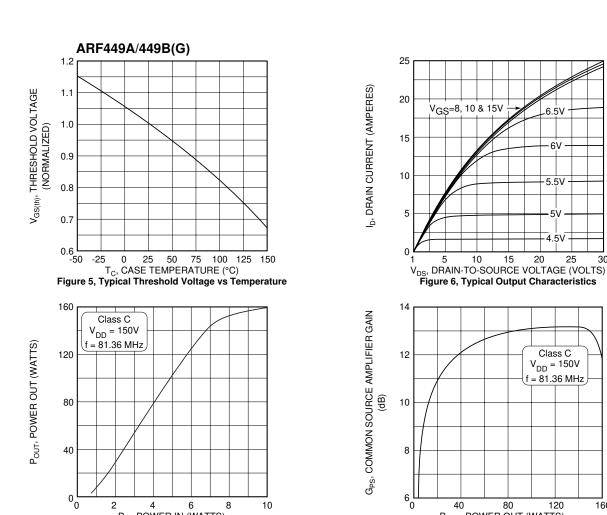
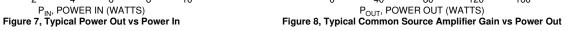


Figure 4, Typical Maximum Safe Operating Area

ID, DRAIN CURRENT (AMPERES)





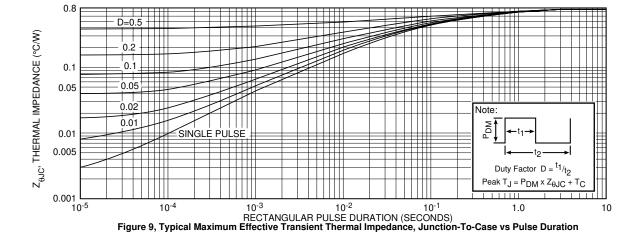


Table 1 - Typical Class C Large Signal Input-Output Impedance

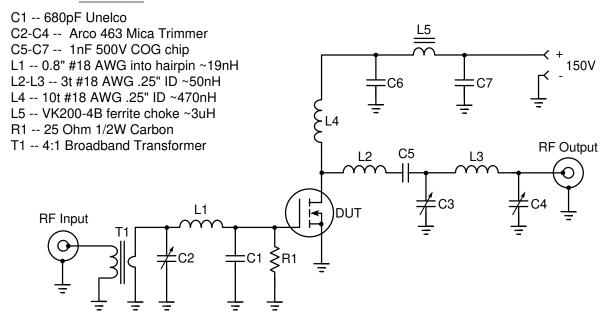
Freq. (MHz)	<b>Z</b> <sub>in</sub> (Ω)	<b>Z</b> <sub>OL</sub> (Ω)
2.0	23.00 - j 7.0	93.0 - j 10
13.5	4.30 - j 9.1	63.0 - j 43
27.0	1.00 - j 4.2	32.0 - j 43
40.0	0.42 - j 1.7	17.5 - j 34
65.0	0.35 + j 1.1	7.7 - j 22
80.0	0.56 + j 2.5	5.1 - j 16
100.0	0.90 + j 3.8	3.4 - j 12

 $Z_{\text{in}}$  - gate shunted by  $25\Omega$ 

Z<sub>OL</sub> - conjugate of optimum load impedance for 150W at 150V

#### 81.36 MHz Test Circuit

## Parts List



#### **TO-247 Package Outline**

e3 100% Sn Plated

